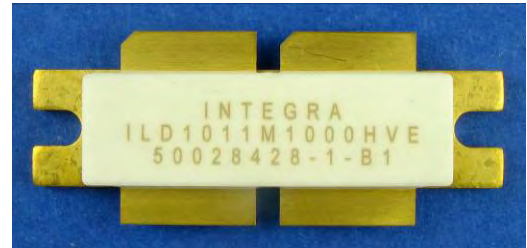


**L-Band Avionics Transistor**

- Silicon LDMOS Technology
- P<sub>OUT-PK</sub> = 1000W @ 50uS, 2%, 50V
- 1030MHz Operating Frequency
- Internal Impedance Pre-matched Device
- Specified For Use Under Class AB Operation
- Metal Based Package Sealed With Ceramic-Epoxy Lid
- Gold Metallization System: Chip - Wire Bond - Package
- Package Size: W=1.620" (41.15mm), L=0.400" (20.30mm)
- 100% High Power RF Tested in Fixed Tuned RF Test Fixture



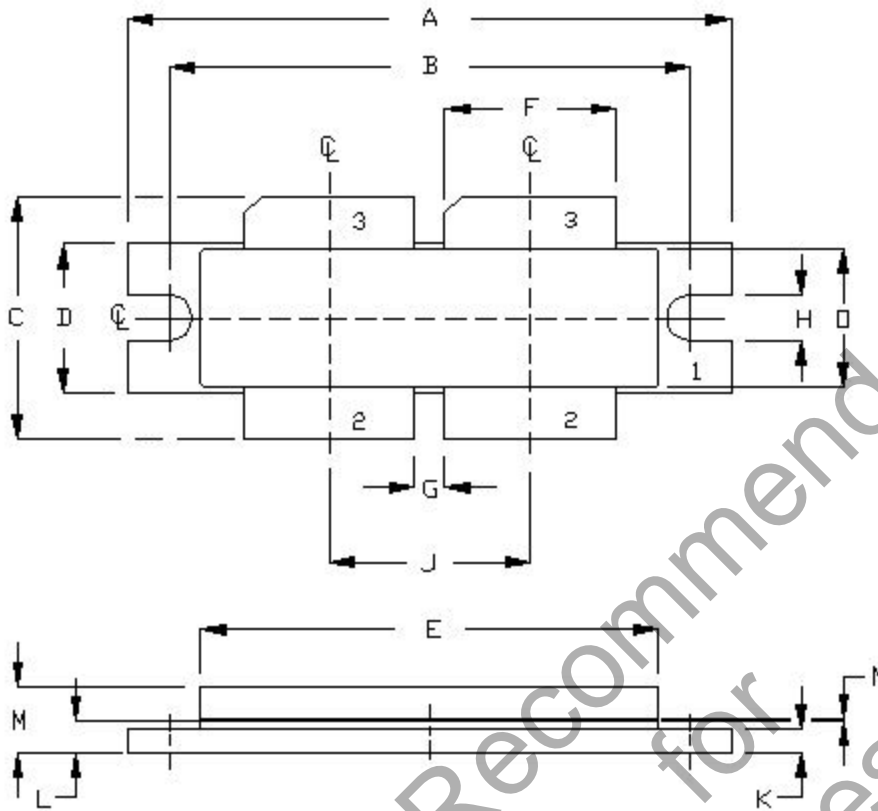
PARAMETER	SYM	MIN	TYP	MAX	UNI	TEST CONDITIONS
<b>DC ELECTRICAL SPECIFICATIONS</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	92	--	--	V	I <sub>DS</sub> =70mA, V <sub>GS</sub> =0V, T <sub>F1</sub> , S1
Drain Leakage Current	I <sub>DSS</sub>	--	--	48	uA	V <sub>DS</sub> =50V, V <sub>GS</sub> =0V, T <sub>F1</sub> , S1
Operating Gate Voltage	V <sub>GS</sub>	1.75	--	5.25	V	V <sub>DS</sub> =5V, I <sub>D</sub> =100mA, T <sub>F1</sub> , S1
Gate Leakage Current	I <sub>GSS</sub>	--	--	1	uA	V <sub>GS</sub> =5V, V <sub>DS</sub> =0V, T <sub>F1</sub> , S1
<b>RF ELECTRICAL SPECIFICATIONS</b>						
Input Return Loss	IRL	-18	-12	-10	dB	PIN1, V1, I <sub>DQ1</sub> , PW1, DF1, F1, T <sub>F1</sub> , S1
Output Power	P <sub>out</sub>	1000	1262	1300	W	PIN1, V1, I <sub>DQ1</sub> , PW1, DF1, F1, T <sub>F1</sub> , S1
Power Gain	G <sub>p</sub>	17.0	18.0	18.5	dB	PIN1, V1, I <sub>DQ1</sub> , PW1, DF1, F1, T <sub>F1</sub> , S1
Drain Efficiency	N <sub>D</sub>	45	55	75	%	PIN1, V1, I <sub>DQ1</sub> , PW1, DF1, F1, T <sub>F1</sub> , S1
Pulse Amplitude Droop	D	-0.50	-0.10	+0.30	dB	PIN1, V1, I <sub>DQ1</sub> , PW1, DF1, F1, T <sub>F1</sub> , S1
Load Mismatch Stability	VSWR-S	2:1	--	--	--	PIN1, V1, I <sub>DQ1</sub> , PW1, DF1, F1, T <sub>F1</sub> , S1
Load Mismatch Tolerance	LMT	3:1	--	--	--	PIN1, V1, I <sub>DQ1</sub> , PW1, DF1, F1, T <sub>F1</sub> , S1

DC & RF TEST CONDITIONS	SYM	MIN	NOM	MAX	UNI	TEST CONDITIONS
Input Power 1	PIN1	--	20	--	W	--
Drain Supply Voltage 1	V1	--	50	--	V	--
Quiescent Drain Current 1	I <sub>DQ1</sub>	--	60	--	mA	--
Pulse Format	PW1	--	50	--	uS	--
Duty Factor 1	DF1	--	2	--	%	--
Frequency 1	F1	--	1030	--	MHz	--
Flange Temperature 1	T <sub>F1</sub>	20	25	30	°C	--

PARAMETER	SYM	MIN	MAX	UNITS	SCREEN	CONDITIONS
<b>MAXIMUM RATINGS</b>						
Drain-Source Voltage	$V_{DS}$	--	92	V	BD	$T_F = 25^\circ\text{C}$
Gate-Source Voltage	$V_{GS}$	-10	12	V	BD	$T_F = 25^\circ\text{C}$
Storage Temperature Range	$T_{STG}$	-55	+150	$^\circ\text{C}$	BD	--
Operating Junction Temperature	$T_J$	-55	+200	$^\circ\text{C}$	BD	--
<b>PROCESS SPECIFICATIONS</b>						
DC Wafer Probe	--	--	--	--	100%	Per Integra Spec
Wafer DC, RF Qualification	--	--	--	--	Q1	Per Integra Spec
Wire Bond Strength	--	--	--	--	LM	Per Integra Spec
Pre-cap Visual Inspection	--	--	--	--	100%	Per Integra Spec
Gross Leak Test – MIL-STD-750D	--	--	--	--	100%	Method 1071.6 C
<b>THERMAL RESISTANCE</b>						
Peak Thermal Resistance Per Rated RF Specification	$R_{TH(JC)}$	--	0.015	$^\circ\text{C/W}$	BD	$T_F = 25^\circ\text{C}$
<b>SCREENING LEVELS</b>						
Screening Level 1	S1	100	--	--	%	--
Parameter Qualified By Design	BD	--	--	--	--	--
Parameter Qualified By 3 Pieces (min) Per Wafer	Q1	--	--	--	--	--
Parameter Qualified By Assembly Line Monitor	LM	--	--	--	--	--

RF TEST FIXTURE – BROADBAND		
▶ Broadband RF Test Fixture. Provides Device Impedance Matching to $50\Omega$ at the Rated Operating Frequency.		
▶ Electronic CAD Drawing File Available Upon Request. Includes Circuit Dimensions and Parts List.		
▶ Reference Design PCB: Rogers 6010.2, DK=10.2.		
FREQUENCY (MHz)	$Z_{IF}(\Omega)$	$Z_{OF}(\Omega)$
1030	$1.30 - j0.22$	$0.41 + j0.10$
Impedance Definition		

PACKAGE OUTLINE DRAWING



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	1.615	1.625	41.02	41.27
B	1.395	1.405	35.43	35.69
C	0.634	0.674	16.10	17.12
D	0.395	0.405	10.03	10.29
E	1.219	1.241	30.96	31.52
F	0.455	0.465	11.56	11.81
G	0.075	0.085	1.90	2.16
H	0.120	0.130	3.05	3.30
J	0.535	0.545	13.59	13.84
K	0.059	0.069	1.499	1.753
L	0.081	0.091	2.06	2.31
M	0.164	0.194	4.16	4.93
N	0.004	0.007	0.10	0.18
Q	0.354	0.364	8.99	9.24

PIN SCHEDULE	
1	SOURCE
2	GATE
3	DRAIN

DEFINITIONS	
<b>DATA SHEET STATUS</b>	
Proposed Specification	This data sheet contains proposed specifications.
Preliminary Specification	This data sheet contains specifications based on preliminary measurements and data.
Product Specification	This data sheet contains final product specifications.
<b>MAXIMUM RATINGS</b>	
Stress above one or more of the maximum ratings may cause permanent damage to the device. These are maximum ratings only operation of the device at these or at any other conditions above those given in the characteristics sections of the specification is not implied. Exposure to maximum values for extended periods of time may affect device reliability.	

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Not Recommended for New Designs